

FEATURES

- Support BC1.2 USB-IF certification
- 4.5V~5.5V Single Supply Operation.
- Automatic USB charger Identification Circuit.
- UC2633B/UC2634B Support Apple® Devices fast charging. (Apple® 2.4A mode)
- Support Samsung Galaxy Tab Devices fast Charging. (Samsung @ 2.1A mode)
- Support BC1.2 & YD/T 1591-2009 Charging Spec. (DCP® 1.0A mode)
- Available in SOT23-6 Package.

APPLICATIONS

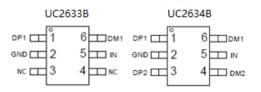
- Power Bank/Car Charger
- USB Wall Adapter
- Travel Charger

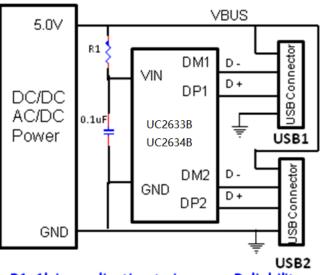
DESCRIPTION

The UC2633B/UC2634B is single/dual USB adapter emulators with automatic host charger identification circuitry for USB dedicated chargers.

The devices integrated automatic USB charger identification circuit allow mobile power supply, In-Car charger, USB wall adapters, travel chargers, and other dedicated chargers to identify themselves as a USB dedicated charger to USB devices, like Apple charger to Apple products, Samsung charger to Samsung Galaxy Tab & Smart Phone, and BC1.2 charger to HTC, SONY, LG, BlackBerry, Lenovo, Coolpad, ZTE, Huawei and other legacy D+/D- short detection devices.

PACKAGE AND APPLICATION





R1=1k in application to improve Reliability



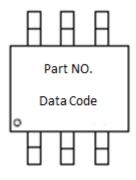
PART NO. TABLE

Part No.	Dual/Single	Apple 12W	Apple 10W	Apple 5W	SS 10W	DCP 5W
UC2633B	Single	Support			Support	Support
UC2634B	Dual	Support			Support	Support

ORDING INFORMATION

Part Number	Package Type	Package Qty	Op Temp(°C)
UC2633B	SOT23-6	3000	-40~85
UC2634B	SOT23-6	3000	-40~85

MARK INFORMATION



ABSOLUTE MAXIMUM RATINGS (1)

Over recommended operating free-air temperature range (unless otherwise noted)

	MIN	MAX	UNIT	
supply voltage range	IN	-0.3	6	V
Input voltage range	DP1,DM1,DP2,DM2	-0.3	5.8	v
Continuous output sink current	DP1,DP2 input current, DM1,DM2 input current		35	
Continuous output source current	DP1,DP2 output current, DM1,DM2 output current		35	mA
ESD rating, Human Body Model	IN		8	kV
(HBM)	DP1,DP2,DM1,DM2		8	КV



Operating Junction Temperature	Tı	-40	125	°C
Storage Temperature Range	T _{stg}	-65	150	C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

THERMAL CHARACTERISTICS

over operating free-air temperature range (unless otherwise noted)

THERMAL METRIC			UNIT
θ_{JA} Package thermal impedance ⁽¹⁾		180	°C/W

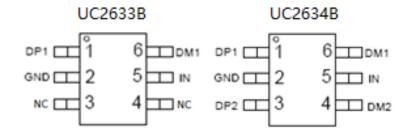
(1) The package thermal impedance is calculated in accordance with JESD 51-7.

RECOMMENDED OPERATING CONDITIONS

	MIN	MAX	UNIT	
V _{IN} Input voltage of IN		4.5	5.5	
V _{DP1/DP2} D+ data line input voltage			5.5	v
Vdm1/dm2	D- data line input voltage		5.5	
I _{DP1/DP2} Continuous sink/source current			±10	
IDM1/DM2 Continuous sink/source current			±10	mA
T _J Operating Junction Temperature		-40	125	°C



PINOUT



NO.	NAME	TYPE ⁽¹⁾	DESCRIPTION
1	DP1	O/I	DP date line to connector, output for hand-shake voltage to portable equipment, high impedance while disabled
2	GND	G	Ground connection
	NC (UC2633B) NC		No Connection
3	DP2 (UC2634B)	O/I	DP date line to connector, output for hand-shake voltage to portable equipment, high impedance while disabled
	NC (UC2633B) NC		No Connection
4	4 DM2 (UC2634B)		DM data line to connector, input for hand-shake voltage from portable equipment high impedance while disabled
5	IN P/I		Power supply/Input voltage connected to Power Switch; connect a 1 μ F or greater ceramic capacitor from IN to GND as close to the IC as possible
6			DM data line to connector, input for hand-shake voltage from portable equipment high impedance while disabled

PIN FUNCTIONS

(1) G = Ground, I = Input, O = Output, P = Power



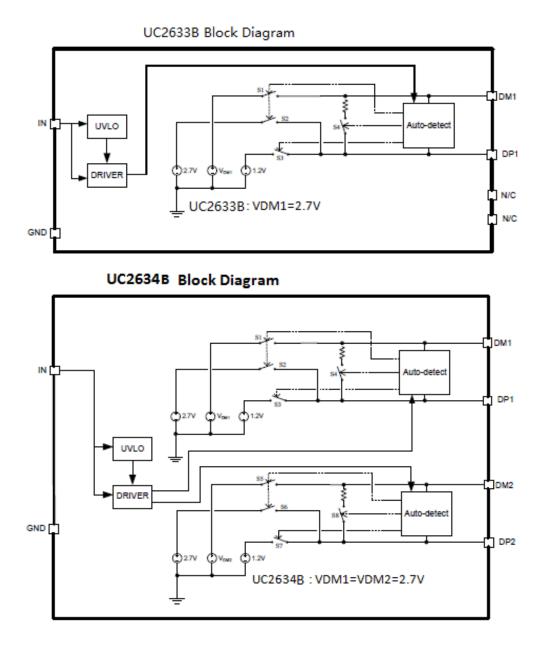
ELECTRICAL CHARACTERISTICS

Conditions are $-40^{\circ}C \le (T_J = T_A) \le 125^{\circ}C$ and $4.5 \text{ V} \le V_{IN} \le 5.5 \text{ V}$ unless otherwise noted. Typical value is at 25°C. All voltages are with respect to GND unless otherwise noted.

P	ARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT			
UNDERVOLTAGE LOCKOUT									
V _{UVLO}	IN rising UVLO threshold voltage		3.9	4.1	4.3	V			
	Hysteresis			100		mV			
	SU	UPPLY CURRENT							
I _{IN}	IN supply current			160	300	μΑ			
BC 1.2 DCP MODE (SHORT)									
R _{DPM_SHORT}	DP / DM shorting resistance	$V_{D+} = 0.8V, I_{D-} = 1mA,$		125	200	Ω			
Rdchg_short	Resistors connected DP /DM to GND after hand-shaking	$V_{D^+} = 0.8 V$		200	400	kΩ			
V _{DPL_TH_} DETACH	DP low threshold while detaching BC1.2 devices		310	330	350	mV			
Vdpl_th_detach_hys	hysteresis			50		mV			
	IPAD MO	ODE(UC2633B/UC2634B)							
VDP_IPAD	DP1/DP2 output voltage	V _{IN} =5.0V	2.55	2.7	2.85	V			
V _{DM_IPAD}	DM1/DM2 output voltage	V _{IN} =5.0V	2.55	2.7	2.85	V			
R _{DP_IPAD}	DP1/DP2 output impedance	$V_{\rm IN}{=}5.0V$, $~I_{D^+}{=}{-}5uA$	20	30	40	kΩ			
R _{DM_IPAD}	DM1/DM2 output impedance	$V_{\rm IN}{=}5.0V$, $~I_{D\text{-}}{=}{-}5uA$	20	30	40	kΩ			
Galaxy Tab MODE									
V_{DP_GAL}	DP1/DP2 output voltage	V _{IN} =5.0V	1.1	1.2	1.3	17			
V _{DM_GAL}	DM1/DM2 output voltage	V _{IN} =5.0V	1.1	1.2	1.3	V			
Rdp_gal	DP1/DP2 output impedance	$V_{\rm IN}{=}5.0V$, $~I_{D{\scriptscriptstyle +}}{=}{-}5uA$	80	105	130	10			
Rdm_gal	DM1/DM2 output impedance	$V_{\rm IN}{=}5.0V$, $~I_{\rm D{\scriptscriptstyle -}}{=}{-}5uA$	80	105	130	kΩ			



FUNCTIONAL BLOCK DIAGRAM





PACKAGE INFORMATION

SOT23-6

